

# **Notice of References Cited**

Application/Control No.

09/612,925

Applicant(s)/Patent Under Reexam

Cano et al.

Examiner

S. Devi, Ph.D.

Art Unit

1645

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## **U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>
A				
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M				

## **FOREIGN PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Country	Name	Classification <sup>2</sup>
N	EP O 474 313 A2	11/03/92	Europe	Rodriguez et al.	----
O					
P					
Q					
R					
S					
T					

## **NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
U	Niebla et al. In: Neisseria 94. Proceedings of the Ninth International Pathogenic Neisseria Conference. (Ed) Evans et al. Winchester, England, 26-30 September 1994, pages 85-86.
V	Nazabal et al. In: Neisseria 94. Proceedings of the Ninth International Pathogenic Neisseria Conference. (Ed) Evans et al. 26-30 September, Winchester, England, pages 98-99, 1994
W	
X	

<sup>1</sup> A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

<sup>1</sup> Dates in MM-YYYY format are publication dates.

<sup>2</sup> Classifications may be U.S. or foreign.

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